

Certificate of Analysis IARM Co6B-18

Cobalt Stellite 6B / UNS R30016 Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

AI	0.07 ± 0.03	С	1.02 ± 0.03	Со	57.0 ± 1.0	Cr	30.7 ± 0.5
Cu	0.015 ± 0.007	Fe	2.68 ± 0.07	Mn	1.48 ± 0.01	Мо	0.020 ± 0.004
Ν	0.017 ± 0.002	Nb	0.014 ± 0.004	Ni	2.59 ± 0.09	Si	0.61 ± 0.05
Ti	0.007 ± 0.002	۷	0.011 ± 0.002	W	3.92 ± 0.04		

Indicative Values listed in ppm											
As (<	<100) B	(6) Ca	(<50)	Η	(<10)	Hf	(<100)	Mg	(<100)	0	(10)
P (4	10) Pb	(<100) Pd	(<10)	S	(<50)	Sb	(<10)	Se	(<50)	Sn	(<100)
Ta (<	<200) Zn	(<100) Zr	(<100)								

Description and Intended Use

This CRM may come in the form of a solid disk, chips, or powder. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Instructions for Use

- 1. The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface.
- 2. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams.
- 3. The material should be stored in a cool, dry location when not in use.
- 4. Chips are not certified for Oxygen analysis.



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	The	following	i data rep	resents a	all pertine	ent inform	iation rep	oned as	it applies	s to the ci	nemicai c	naracter	ization of	this mate	erial.	
	Al	As	В	С	Ca	Co	Cr	Cu	Fe	Н	Hf	Mg	Mn	Мо	N	Nb
1	0.0282	0.023	0.0002	0.972	0.0011	56.2728	29.923	0.008	2.5647	0.0001	0.0153	0.00026	1.45957	0.00991	0.0149	0.00681
2	0.0398	<0.01	0.000778	0.997	< 0.001	56.5167	30.10	0.0082	2.58	0.0002	< 0.001	< 0.001	1.46	0.011	0.015	0.01057
3	0.058	< 0.005	0.0008	1.0163	< 0.005	56.593	30.207	0.00937	2.607	< 0.001	< 0.005	< 0.001	1.474	0.01751	0.0162	0.0131
4	0.06501		< 0.001	1.02		57.198	30.26	0.011	2.61		<0.01	< 0.005	1.4767	0.019	0.0164	0.014
5	0.0692		< 0.005	1.02		57.5033	30.2633	0.0115	2.641			< 0.01	1.4786	0.021	0.017	0.015
6	0.07		< 0.01	1.02		58.491	30.28	0.01237	2.679				1.482	0.021	0.018	0.016
7	0.086			1.03		59.70	31.05	0.01393	2.68				1.50	0.0223	0.01982	0.02
8	0.135			1.0997			31.1965	0.025	2.7867				1.5003	0.02277		< 0.005
9							31.36	0.03405	2.801					0.024		
10							31.957		2.8477					0.027		
11														0.0278		
12																
13																
14																
15																
Mean	0.07		0.0006	1.02		57.0	30.7	0.015	2.68				1.48	0.020	0.017	0.014
STDV.	0.03		0.0003	0.04		1.0	0.7	0.009	0.10				0.02	0.006	0.002	0.004
Certified	0.07	(<0.01)	(0.0006)	1.02	(<0.005)	57.0	30.7	0.015	2.68	(<0.001)	(<0.01)	(<0.01)	1.48	0.020	0.017	0.014
U _{CRM}	0.03			0.03		1.0	0.5	0.007	0.07				0.01	0.004	0.002	0.004
Methods	I,X	I		С	I	I,X,O	I,X,O	I,X,O	I,X,O	C,F,I	I,X		I,X	I,O,X	C,F	I,X,O
	Ni	0	Р	Pb	Pd	S	Sb	Se	Si	Sn	Та	Ti	v	w	Zn	Zr
1	2.4567	0.000591	0.0029	<0.01	< 0.001	0.0042	0.00005	0.0001	0.534	0.00005	0.009	0.00413	0.007333	3.81	0.00043	0.00065
2	2.4767	0.000667	0.004	<0.001		< 0.001	0.00073	<0.001	0.54307	0.0022	0.0193	0.0042	0.008533	3.8696	0.004	0.002
3	2.49	0.00069	0.004433	<0.01		< 0.0003	< 0.001	< 0.005	0.566	<0.01	< 0.001	0.00577	0.0096	3.8733	<0.01	0.017
4	2.521	0.001	0.0048			< 0.0005			0.57	< 0.001	< 0.001	0.007	0.0097	3.883		< 0.001
5	2.5244	0.00192	< 0.005			<0.001			0.57767	<0.01	< 0.005	0.007	0.01	3.895		< 0.005
6	2.535	< 0.001	< 0.001			<0.001			0.6115		<0.01	0.00797	0.01	3.904		
7	2.713	< 0.0010	< 0.005			<0.001			0.62			0.0107	0.011	3.914		
8	2.716		< 0.005						0.65833			0.012	0.011	3.9562		
9	2.72								0.7091				0.012	3.99		
10	2.7724								0.713				0.01362	3.99		
11													0.016	4.014		
12																
13																
14																
15	0.50	0.0046	0.000									0.007	0.044	0.00		
15 Mean	2.59	0.0010	0.003						0.61			0.007	0.011	3.92		
15 Mean STDV.	0.10	0.0006	0.002	(-0.01)	(-0.001)	(-0.005)	(-0.001)	(-0.005)	0.06	(-0.01)	(-0.02)	0.003	0.002	0.06	(-0.01)	(-0.02)
15 Mean STDV. Certified	0.10 2.59			(<0.01)	(<0.001)	(<0.005)	(<0.001)	(<0.005)	0.06 0.61	(<0.01)	(<0.02)	0.003 0.007	0.002 0.011	0.06 3.92	(<0.01)	(<0.02)
15 Mean STDV. Certified U _{CRM}	0.10 2.59 0.09	0.0006 (0.001)	0.002 (0.004)	(<0.01)	(<0.001)		(<0.001)	(<0.005)	0.06 0.61 0.05	(<0.01)		0.003 0.007 0.002	0.002 0.011 0.002	0.06 3.92 0.04	(<0.01)	(<0.02)
15 Mean STDV. Certified	0.10 2.59	0.0006	0.002	(<0.01) I	(<0.001)	(<0.005) C,X	(<0.001)	(<0.005) I	0.06 0.61	(<0.01)	(<0.02) I,X	0.003 0.007	0.002 0.011	0.06 3.92	(<0.01)	(<0.02) I,X

Certification Laboratories

NSL Analytical Services, Inc. IMR Test Labs EAG Laboratories, Inc. Connecticut Metallurgical Inc. Cleveland, OH Lansing, NY Liverpool, NY East Hartford, CT Massachusetts Materials Research, Inc. **Dirats Laboratories** Applied Technical Services, Inc. VHG Labs ATI Specialty Materials, Monroe

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West Boylston, MA Westfield, MA Marietta, GA Manchester, NH Monroe, NC

Certification laboratories have demonstrated performance and traceability by utilizing test methods under the scope of ISO 17025 or have shown competence through a proficiency testing program. Some of the specific CRMs and SRMs used in the analysis of the material covered by this certificate are:

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (Uhom). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1.
$$N_{min} = \max(10, \sqrt[3]{N_{prod}})$$

$$U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Expiration

The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

David Coler, General Manager Analytical Reference Materials International



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